

Notice of References CitedApplication/Control No.
09/832,786Applicant(s)/Patent Under
Reexamination
DILLER ET AL.Examiner
Cheyne D LyArt Unit
1631

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	B	US-			
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	I	US-			
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	L	US-			
	M	US-			

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NON-PATENT DOCUMENTS

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	U	Jan Drenth, Principles of Protein X-ray Crystallography, 1995, Springer-Verlag, page 16.
	V	News Focus, Science, November 1, 2002, Volume 298, Pages 948-950.
	W	Ho et al., Proceedings of the Twenty-seventh Annual Hawaii International Conference on System Sciences, 1994, Volume V, pages 213-222.
	X	Aldenderfer et al., Cluster Analysis, Sage University Paper, pages 33-40, 1984.

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.